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Application/Control No.	Applicant(s)/Patent under Reexamination
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Jason H. Johnsen

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Class	Subclass	Date	Examiner
514	∙054	1/22/2005	JHJ
514	294	1/22/2005	JHJ
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East-see printout	1/16/2005	JHJ
STN-see printout	10/4/2005	EW
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